

Notice of References Cited	Application/Control No. 10/585,315		Applicant(s)/Patent Under Reexamination HIRANO ET AL.	
	Examiner MYRON WYCHE		Art Unit 2617	Page 1 of 1

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*	B	US-2003/0026241	02-2003	Ono et al.	370/349
*	C	US-2003/0103496	06-2003	Lakshmi Narayanan et al.	370/352
*	D	US-2004/0156347	08-2004	Kim, Pyung-soo	370/338
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NON-PATENT DOCUMENTS

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